WHAT IS CLAIMED IS:

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1. A method for separating a mask from the surface of a semiconductor wafer when configured as a mask/wafer combination, comprising the steps of:

mounting the mask/wafer combination on a rotatable surface;

rotating the rotatable surface;

inserting a separating device at the edge of the mask between the two mating surfaces of the mask and the semiconductor wafer; and

urging the separating device toward the rotating center of the mask/wafer combination while the rotatable surface is rotating.

- 2. The method of Claim 1, wherein the surface of the semiconductor wafer diametrically opposite the mask is disposed proximate to the surface of the rotatable surface.
- 3. The method of Claim 2, further comprising the step of moving the rotatable surface away from the separating device with the semiconductor wafer attached thereto.
- 4. The method of Claim 3, wherein the step of moving the rotatable surface comprises the moving the rotatable surface as a function of the movement of the separator device toward the rotating center of the mask/wafer combination.
 - 5. The method of Claim 1, wherein the mask comprises a metal mask.
 - 6. The method of Claim 5, wherein the metal mask comprises a shadow mask.
 - 7. The method of Claim 1, wherein the separating device comprises a wedge shaped device.
- 8. The method of Claim 1, further comprising the step of programming the rotational speed of the rotatable surface.

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- 9. The method of Claim 1, wherein the mask/wafer combination is held onto the rotatable surface by a vacuum.
- 10. The method of Claim 1, and further comprising the step of urging the surface of the mask/wafer combination downward as the separating device is moved toward the rotating center of the mask/wafer combination while the rotatable surface is rotating.
- 11. A shadow mask removal system for separating a mask from the surface of a semiconductor wafer when configured as a mask/wafer combination, comprising:

a rotatable surface for receiving in a mounting relationship the mask/wafer combination; a rotation apparatus for rotating the rotatable surface;

- a separating device operable to be inserted at the edge of the mask between the two mating surfaces of the mask and the semiconductor wafer; and
- a motive device for urging the separating device toward the rotating center of the mask/wafer combination while the rotatable surface is rotating.
- 12. The shadow mask removal system of Claim 11, wherein the surface of the semiconductor wafer diametrically opposite the mask is disposed proximate to the surface of the rotatable surface.
- 13. The shadow mask removal system of Claim 12, wherein the motive device is operable to move the rotatable surface away from the separating device with the semiconductor wafer attached thereto.
- 14. The shadow mask removal system of Claim 13, wherein the motive device is operable to move the rotatable surface as a function of the movement of the separator device toward the rotating center of the mask/wafer combination.
- 15. The shadow mask removal system of Claim 11, wherein the mask comprises a metal mask.

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- 16. The shadow mask removal system of Claim 15, wherein the metal mask comprises a shadow mask.
- 17. The shadow mask removal system of Claim 11, wherein the separating device comprises a wedge shaped device.
- 18. The shadow mask removal system of Claim 11, further comprising a program device for programming the rotational speed of the rotatable surface.
- 19. The shadow mask removal system of Claim 11, wherein the mask/wafer combination is held onto the rotatable surface by a vacuum device.
- 20. The shadow mask removal system of Claim 11, and further comprising a vertical motive device for urging the surface of the mask/wafer combination downward as the separating device is moved toward the rotating center of the mask/wafer combination while the rotatable surface is rotating.

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